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| Substitute for form 1449A/PTO & 1449B/PTO | | Complete if Known | |
| FIRST INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary) | | Application Number | 10/595104 |
| | | Filing Date | June 30, 2006 |
| | | First Named Inventor | Seiji HIRAKAWA et al. |
| | | Examiner Name | |
| Sheet | 1 of 1 | Attorney Docket Number | 1033413-000014 |

U.S. PATENT DOCUMENTS

| Examiner Initials | Document Number | Kind Code (if known) | Name of Patentee or Applicant of Cited Document | Issue/Publication Date (MM-DD-YYYY) |
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FOREIGN PATENT DOCUMENTS

| Examiner Initials | Document Number | Kind Code (if known) | Country | Date of Publication (MM-DD-YYYY) | STATUS | | | | | |
|-------------------|-----------------|----------------------|---------|----------------------------------|-------------|---------------------|--------------------|---------------|------|---------------|
| | | | | | Translation | Partial Translation | Eng. Lang. Summary | Search Report | IPER | Abstract Spec |
| /IK/ | * 03-111694 | A | Japan | 05-13-1991 | | | | X | | X |
| /IK/ | * 09-170770 | A | Japan | 06-30-1997 | | | | X | | X |
| /IK/ | * 2004-150789 | A | Japan | 05-27-2004 | | | | X | | X |
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NON-PATENT LITERATURE DOCUMENTS

| Examiner Initials | Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. |
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| Examiner Signature | /Igor Kershteyn/ | Date Considered | 09/24/2008 |
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